

<b>Notice of References Cited</b>	Application/Control No. 10/783,783		Applicant(s)/Patent Under Reexamination KLENK ET AL.	
	Examiner DIANE YABUT		Art Unit 3734	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0059984	03-2005	Chanduszko et al.	606/151
*	B	US-6,485,504	11-2002	Johnson et al.	606/216
*	C	US-5,662,683	09-1997	Kay, David B.	606/232
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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